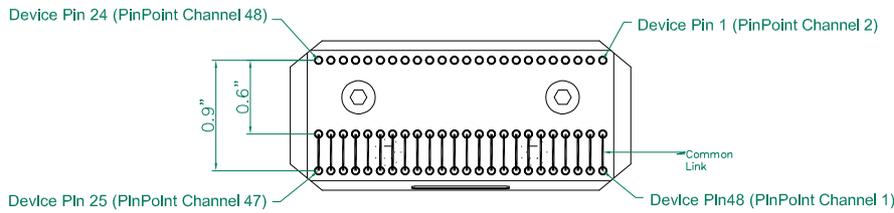
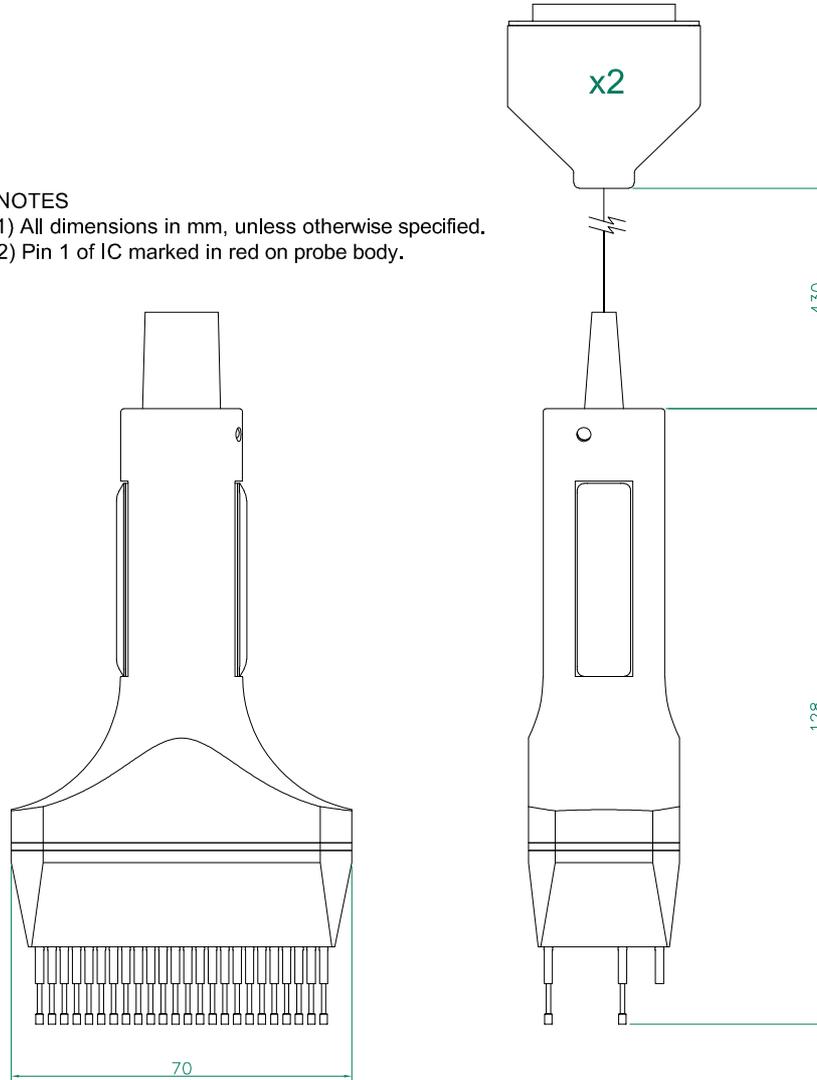


**Connections Table**

<b>Device Pin</b>	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	19	20	21	22	23	24
<b>Pinpoint Channel</b>	2	4	6	8	10	12	14	16	18	20	22	24	26	28	30	32	34	36	38	40	42	44	46	48
<b>Device Pin</b>	25	26	27	28	29	30	31	32	33	34	35	36	37	38	39	40	41	42	43	44	45	46	47	48
<b>Pinpoint Channel</b>	47	45	43	41	39	37	35	33	31	29	27	25	23	21	19	17	15	13	11	9	7	5	3	1

**KEY**  
**BLUE** = Connector 'A'  
**RED** = Connector 'B'

**NOTES**  
1) All dimensions in mm, unless otherwise specified.  
2) Pin 1 of IC marked in red on probe body.



**Maintenance**

The Test Interface Head is maintenance free. Immersion in water or contact between microprobes and any liquids should be avoided, as this could severely reduce the working life of the probes.

Contamination is the primary cause of probe contact problems. This is generally caused by flux left as a residue on circuit boards. Other probe contaminants such as dust, fluff, oil and grime can also cause problems in other areas. Light brushing of the tips of the probes with nylon, bristle or soft metal brushes will dislodge most contaminants.